Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,495	JUN, JIN-HWI	
Examiner	Art Unit	
Julian D. Huffman	2853	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	19,37	5/17/2006	JH
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INTE	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
347	19,37	5/17/2006	JH
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	DATE	EXMR
Updated Search	5/17/2006	JH
		